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Substitute for form 1449A/B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Application Number	10/529,473
				Filing Date	March 28, 2005
				First Named Inventor	Jarmo RUOHONEN
				Art Unit	N/A 3737
				Examiner Name	Not Yet Assigned J Cwern
Sheet	1	of	1	Attorney Docket Number	0365-0625PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
J.C.	AA	US-2005/0075560-A1	04-07-2005	Hannula et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
J.C.	BA	EP-1176558-A2	01-30-2002	Steckner et al.		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
J.C.	CA	"Model Extraction from Magnetic Resonance Volume Data Using the Deformable Pyramid," Lotjonen et al., <i>Medical Image Analysis</i> , Vol. 3, No. 4, 1999, pp. 387-406.	

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Jonathan Cwern/	Date Considered	09/21/2007
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		Number-Kind Code ² (if known)			
J.C./	AA	US-6,236,875-B1	05-22-2001	BUCHOLZ et al.	
J.C./	AB	US-4,680,856	07-21-1987	ZUCCARELLI	
J.C./	AC	US-2003/0073899-A1	04-17-2003	RUOHONEN et al.	
J.C./	AD	US-5,291,889-A	03-08-1994	KENET et al.	

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		Country Code ³ -Number ⁴ -Kind Code ⁵ (If known)				
J.C.	BA	EP-1 17 6558-A2	01-30-2002			
J.C.	BB	EP-1 270 043-A1	01-02-2003			
J.C.	BC	WO-03/082405-A1	10-09-2003			
J.C.	BD	WO-99/59106-A1	11-18-1999			
J.C.	BE	WO-93/20749-A1	10-28-1993			
J.C.	BF	WO-00/10034-A1	02-24-2000			

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J.C./	CA	ETTINGER et al., Mathematical Methods in Biomedical Image Analysis, Proceedings of the Workshop, June 21-22, 1996, pages 32-41.	

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